



Subject card

Subject name and code	, PG_00052090						
Field of study	Metody mikroskopowe w nanotechnologii						
Date of commencement of studies	October 2023		Academic year of realisation of subject		2025/2026		
Education level	first-cycle studies		Subject group		Optional subject group Subject group related to scientific research in the field of study		
Mode of study	Full-time studies		Mode of delivery		at the university		
Year of study	3		Language of instruction		Polish		
Semester of study	5		ECTS credits		4.0		
Learning profile	general academic profile		Assessment form		assessment		
Conducting unit	Division of New Functional Materials For Energy Conversion -> Institute of Nanotechnology and Materials Engineering -> Faculty of Applied Physics and Mathematics -> Wydziały Politechniki Gdańskiej						
Name and surname of lecturer (lecturers)	Subject supervisor		dr hab. inż. Jakub Karczewski				
	Teachers		dr hab. inż. Jakub Karczewski				
Lesson types	Lesson type	Lecture	Tutorial	Laboratory	Project	Seminar	SUM
	Number of study hours	15.0	0.0	15.0	15.0	0.0	45
	E-learning hours included: 0.0						
	eNauczanie source address: https://enauczanie.pg.edu.pl/2025/course/view.php?id=2289						
	Moodle ID: 2289 Metody mikroskopowe w nanotechnologii https://enauczanie.pg.edu.pl/2025/course/view.php?id=2289						
Learning activity and number of study hours	Learning activity	Participation in didactic classes included in study plan		Participation in consultation hours		Self-study	SUM
	Number of study hours	45		6.0		49.0	100
Subject objectives	Understanding modern methods of imaging nanostructures.						
Learning outcomes	Course outcome		Subject outcome		Method of verification		
	K6_W10		The student is able to prepare, perform and interpret an experiment in the field of modern maging methods.		[SW1] Ocena wiedzy faktograficznej		
	K6_K04		The student is able to plan and perform an experiment in the field of modern imaging methods in cooperation with a group.		[SK1] Ocena umiejętności pracy w grupie [SK4] Ocena umiejętności komunikacji, w tym poprawności językowej		
	K6_W09		The student knows and understands the principles of operation and is able to perform measurements using SEM, AFM, STM microscopy.		[SW1] Ocena wiedzy faktograficznej		
	K6_U04		The student is able to prepare, perform and interpret an experiment in the field of modern imaging methods.		[SU2] Ocena umiejętności analizy informacji [SU3] Ocena umiejętności wykorzystania wiedzy uzyskanej w ramach przedmiotu [SU4] Ocena umiejętności korzystania z metod i narzędzi		

Subject contents	Understanding the theoretical foundations of microscope operation: <ul style="list-style-type: none">• optical microscopy• tunneling microscopy• atomic force microscopy• scanning electron microscopy• transmission electron microscopy		
	Learn the practical use of microscopes: <ul style="list-style-type: none">• optical microscopy• atomic force microscopy• scanning electron microscopy		
	using knowledge of microscopic methods to independently create a concept, plan, and implement any scientific project using microscopic imaging		
Prerequisites and co-requisites	knowledge of basic physics		
Assessment methods and criteria	Subject passing criteria	Passing threshold	Percentage of the final grade
	presentation of laboratory results	50.0%	50.0%
	exam	50.0%	50.0%
Recommended reading	Basic literature	<ul style="list-style-type: none">• Weillie Zhou Zhong Lin Wang "Scanning Microscopy Techniques and Applications"• V. L.Mironov"Fundamentals of Scanning Probe Microscopy"	
	Supplementary literature	<ul style="list-style-type: none">• Nanosurf easyScan 2 - operating instruction	
	eResources addresses		
Example issues/ example questions/ tasks being completed	<ul style="list-style-type: none">• principle of atomic force microscopy methods• limitations of SEM microscopy• comparison of nanostructure imaging		
Practical activites within the subject	Not applicable		

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